Department of ECE

Name: Dr D Naga Ravi kiran

Designation: Associate professor

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Qualification: Ph.D

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Faculty(Details)

International /National Journals:

- D.Naga Ravikiran and Dr C.G. Dethe, "Energy efficient data aggregation in sensor networks
 with optimized cluster head selection" in International Journal of Computer, Electrical,
 Automation, Control and Information Engineering Vol. 9, No. 6, 2015.
- D.Naga Ravikiran and Dr C.G. Dethe, "Fuzzy Rule Selection using LEACH Algorithm to Enhance Life Time in Wireless Sensor Networks" in International Journal of Advances in Wireless and Mobile Communications. ISSN 0973-6972, Volume 10, Number 3 (2017), pp. 469-477.
- D.Naga Ravikiran and Dr C.G. Dethe, "fuzzy rule selection using Artificial Bee Colony optimization algorithm" In International research Journal of Advanced Intelligence Paradigms, Inderscience publishers, Scopus indexed Vol. 12, Nos. 1/2, 2019, pp 164-177.
- 4. D.Naga Ravikiran and Dr C.G. Dethe, "Improvements in Routing Algorithms to Enhance Lifetime of Wireless Sensor Networks" In The International Journal of Computer Networks & Communications (IJCNC), Scopus indexed, March 2018, volume 10, Number 2.
- 5. Dr D.Naga Ravikiran and U.Mounika "A design of ATM monitoring and security system based on sensors using IoT" In The International Journal of The International Journal Of Analytical And Experimental Modal Analysis (IJAEMA), UGC-CARE approved journal, January 2021, volume XIII, Issue 1, ISSN NO: 0886-9367.

Conferences Coordinated/Attended

 D.Naga Ravikiran and D Prabhakar, "Sparse channel estimation for massive MIMO OFDM systems" In 2nd International conference on Recent challenges in science, engineering and technology (ICRCSET-2020) held at chalapathi institute of technology, Mothadaka, Guntur,

- from 28th to 29th February, 2020
- 2. D.Naga Ravikiran and Dr C.G. Dethe, "fuzzy rule selection using Artificial Bee Colony optimization algorithm to enhance life time in multi hop wireless sensor networks" In 7th IEEE International Advanced Computing Conference (IACC- 2017) held at VNR Vignana Jyothi Institute of Engineering & Technology, Hyderabad, from 5th to 7th January, 2017.

FDP's and Workshops Attended/Coordinated:

- Attended AICTE-ISTE short term training program on 5G cognitive training program conducted by Department of ECE, chalapathi institute of technology, Mothadaka, Guntur, from 17th to 22nd January, 2022
- 2. Attended Faculty development programme on Digital VLSI Design and Verification conducted by Department of ECE, Bangalore Institute of Technology in association with Entuple Technologies and IEEE-BIT CAS from 23-08-2021 to 28-08-2-2021.
- 3. Attended Faculty development programme on "Internet of Things" conducted by chalapathi institute of technology, Mothadaka, Guntur, from 09th to 11th January, 2020
- 4. Attended Faculty development programme on AI conducted by chalapathi institute of technology, Mothadaka, Guntur, from 24^{th} to 29^{th} May, 2020
- 5. Attended Faculty development programme on Machine learning and Aritificial intelligence conducted by IEEE Bombay section from 23rd May 2020 to 27th May 2020
- 6. Attended and acted as Co-convener at the International conference on Recent challenges in science, engineering and technology (ICRCSET-2020) held at chalapathi institute of technology, Mothadaka, Guntur, from 28th to 29th February, 2020.
- 7. Attended and submitted research paper in "7th IEEE International Advance Computing Conference (IACC-2017) at VNRVJIET, Hyderabad from Jan 5th 7th 2017.
- 8. Attended Two week Short Term Training Programme on Effective Research Methodology sponsored by ISTE, during 05-10-2015 to 16-10-2015 at Priyadarshini Institute of Engineering and technology, Nagpur, Maharastra.
- 9. Attended one day Research and Development facilitation workshop organized by The Institution of Engineers (India), Vijayawada local center, on 29-03-2015.

Professional Memberships

S.No	Organization	Membership Number	Membership Type
1	ISTE	LM117623	Life time

2	IAENG	293873	Life time